Application/Control No. Og/504,964 Examiner Tianjie Chen Applicant(s)/Patent Under Reexamination SHINJO ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,095,397 A	03-1992	Nagata et al.	360/318
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